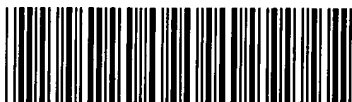


**Search Notes**

Application/Control No.

10/522,681

Examiner

Luan K. Bui

Applicant(s)/Patent under  
Reexamination

NISHIO, MITSUHIRA

Art Unit

3728

**SEARCHED**

Class	Subclass	Date	Examiner
206	213.1	2/2/2007	LKB
	219-220		
	438, 568		
53	432-434		
	455, 512		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR